



PTO/SB/08 A & B (08-03)

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Complete if Known	
				Application Number	10/616,896
				Filing Date	July 9, 2003
				First Named Inventor	Quake, Stephen R.
				Art Unit	2878
				Examiner Name	Patrick J. Lee
Sheet	1	of	1	Attorney Docket Number	020859-001310US

U.S. PATENT DOCUMENTS+					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number Kind Code ² (if known)			
	1	US 6,850,323	02-01-2005	Anderson	

FOREIGN PATENT DOCUMENTS								
Examiner Initials*	Cite No. ¹	Foreign Patent Document			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ²
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)				

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	2	GERTON et al., Tip-Enhanced Fluorescence Microcopy at 10 Nanometer Resolution, Department of Applied Physics, CALTECH, MC 128-95, Pasadena, CA, 2004.	
	3	KAWATA et al., Feasibility of Molecular-Resolution Fluorescence near-field Microscopy using Multi-Photon Absorption and Field Enhancement near a sharp tip, Journal of Applied Physics, Volume 85, Number 3, 1999.	
	4	SANCHEZ et al., Near-Field Fluorescence Microscopy Based on Two-Photon Excitation with Metal Tips, Physical Review Letters, Volume 82, Number 20, 1999.	

Examiner Signature		Date Considered	8/10/2005
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.